

**Notice of References Cited**

Application/Control No.

10/791,629

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

Jermele M. Hollington

Art Unit

2829

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0176620 A1	08-2007	SHIM et al.	324/765
*	B	US-2008/0042667 A1	02-2008	Yamashita et al.	324/754
*	C	US-2008/0079456 A1	04-2008	LEE, Sung-soo	324/765
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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